

<b>Notice of References Cited</b>		Application/Control No. 10/591,861	Applicant(s)/Patent Under Reexamination PROKSCHA ET AL.	
		Examiner Naishadh N. Desai	Art Unit 2834	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,187,858 A	02-1993	Murakoshi et al.	29/596
*	B	US-5,763,978 A	06-1998	Uchida et al.	310/215
*	C	US-6,400,059 B1	06-2002	Hsu, Chun-Pu	310/254
*	D	US-6,583,530 B2	06-2003	Hsu, Chun-Pu	310/254
*	E	US-2003/0160537 A1	08-2003	Hsu, Chun-Pu	310/254
*	F	US-6,737,785 B2	05-2004	De Luca et al.	310/218
*	G	US-2004/0124734 A1	07-2004	Liao, Gordon	310/218
*	H	US-2005/0212378 A1	09-2005	Wang et al.	310/260
*	I	US-6,983,528 B1	01-2006	Muller et al.	29/596
*	J	US-7,105,976 B2	09-2006	Stewart et al.	310/218
*	K	US-7,116,023 B2	10-2006	Wang et al.	310/71
*	L	US-7,116,031 B2	10-2006	Ahn, Byung Hwan	310/216
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages).
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.